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## AP3 Rec'd PCT/PTO 07 JUN 2006

#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Youichi ARAI.

Serial Number: Not Yet Assigned

(§371 of International Application PCT/JP05/00679)

Filed: June 7, 2006

For. METHOD OF MEASURING INTRINSIC RESISTANCE OF BATTERY AND APPARATUS OF SAME

#### INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

June 7, 2006

Sir:

In compliance with 37 CFR 1.56, Applicant calls to the attention of the Patent and Trademark Office the references listed on the attached PTO-1449 and cited in the enclosed international search report. References AE-AF are cited in the international search report.

A copy of each of the references is enclosed herewith.

In the event there are any fees due in connection with the filing of this paper, please charge Deposit Account No. <u>01-2340</u>.

Respectfully submitted, ARMSTRONG, KRATZ, QUINTOS,

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JEA/jaz Atty. Docket No. **060424** Suite 1000 1725 K Street, N.W. Washington, D.C. 20006 (202) 659-2930

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PATENT TRADEMARK OFFICE

Enclosures: PTO-1449; References (3); International Search Report

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INFORMATION	Atty. Docket No. 060424	Serial No. New Application	
DISCLOSURE STATEMENT	Applicant(s): Youichi ARAI		
PTO-1449	Filing Date: June 7, 2006	Group Art Unit: Not Yet Assigned	

### **U.S. PATENT DOCUMENTS**

Examiner Initial		Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
	AA						
	AB						
	AC						
	AD						

### FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Translation (Yes or No)
	AE	2003-177163	06/27/03	Japan	No
	AF	2003-177164	06/27/03	Japan	No
	AG	2003-115331	04/18/03	Japan	Yes-Abstract/Discussed in the specification
	AH				
<u> </u>	AI				

### **OTHER DOCUMENTS**

	AJ	
	AK	
Examiner		Date Considered